Neifeld Ref: VISX0011U/US

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Telfair et al.

INT APP. NO: 09/307,988

FILED: 5/10/1999

FOR: Short Pulse Mid-Infrared Parametric Generator for Surgery

GAU:3739

EXAMINER: SHAY

PTO CONFIRMATION NO. 5573

37 CFR 1	.97 INFORMATION D	DISCLOSURE STATEMEN	ΙΤ
ASSISTANT COMMISSIONER FOR F ALEXANDRIA, VA 22313	ATENTS	·	
SIR: Applicant(s) wish to disclose the f	ollowing information.	•	
being submitted herewith or, v of relevancy or any readily ava by the examiner.	vere submitted in the parent or gra	the attached PTO-1449. Copies of the indparent application, where required, a tinent portions of any non-English langu	s were either statements
RELATED CASES Attached is a list of applicant' A copy of the patent(s) is attac		patent(s) which may be related to the p	resent application.
A check is attached in the amo	unt required under 37 CFR §1.17	(p).	
office in a counterpart foreign No item of information contain office in a counterpart foreign	application not more than three med in this information disclosure application or, to the knowledge	re statement was cited in a communication this prior to the filing of this statemen statement was cited in a communication of the undersigned, having made reason e months prior to the filing of this stater	nt. n from a foreign patent able inquiry, was known
PETITION Applicant(s) hereby request correquired under 37 CFR §1.17(nation. A check is attached in the amou	nt of the Petition fee
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31518 PATENT TRADEMARK OFFICE	5/01/08	Respectfully submitted,	TECHNOLOGY CENTER R3700
	Date	Richard A. Neifeld Registration No. 35,299	

Printed: May 14, 2003 (3:24pm)
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NEIFELD IP LAW REFERENCE FORM LIST OF REFERENCES CITED BY THE APPLICANT (Rev: 5/14/2003)	NEIFELD REF: VISX0011U/US APPLICATION NO: 09/307,988			
	FIRST NAMED INVENTOR: Telfair			
	FILING DATE: 5/10/1999	GROUP ART UNIT: 3739		

LISTING OF UNITED STATES PATENTS - II series

EXAMINER INITIALS	REFERENCE NUMBER (U SERIES)	PATENT NUMBER	ISSUE DATE	NAME OF PATENTEE OR APPLICANT	PAGE/LINE AND FIGURE/ELEMENT OF RELEVANT MATERIAL AND/OR IDENTIFICATION OF PRIORITY APPLICATION IN WHICH REFERENCE IS CITED
			 		
		 			
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Page 1 of 4

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LISTING OF UNITED STATES PUBLISHED APPLICATIONS - P Series

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LISTING OF FOREIGN AND INTERNATIONAL PATENT DOCUMENTS - F Series

EXAMINER INITIALS	REFERENCE NUMBER (F SERIES)	PUBLICATION NUMBER	PUBLICATION DATE	COUNTR Y OR REGION	PAGE/LINE AND FIGURE/ELEMENT OF RELEVANT MATERIAL	ENGLISH LANGUAGE TRANSLATION ATTACHED? (YES OR NO) AND/OR IDENTIFICATION OF PRIORITY APPLICATION IN WHICH REFERENCE IS CITED
	F-001		id-Open H3-94750	/1991,		Yes
		priority: US 363,1 corresponding to	priority: US 363,174, June 7, 1989, corresponding to US 5,152,759. JP National Phase Publication			
	F-002	\dashv				English Abstract
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LISTING OF NON PATENT LITERATURE - O Series

EXAMINER INITIALS	REFERENCE NUMBER (L. Series)	PUBLICATION DATE	INCLUDE IN SEQUENCE: Name of first author (in CAPITAL LETTERS), Tale in quotation marks, name of publication, date or publication, page numbers, publisher, city of publication, and country of publication	ENGLISH LANGUAGE TRANSLATION ATTACHED? (YES OR NO) AND/OR OR IDENTIFICATION OF PRIORITY APPLICATION IN WHICH REFERENCE IS CITED			
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Date:	Date: Examiner's Signature:						